

74VCX00 Low Voltage Quad 2-Input NAND Gate with 3.6V Tolerant Inputs and Outputs

Features

- 1.2V to 3.6V V_{CC} supply operation
- 3.6V tolerant inputs and outputs
- t_{PD}
 - 2.8ns max. for 3.0V to 3.6V V_{CC}
- Power-off high impedance inputs and outputs
- Static Drive (I_{OH}/I_{OL})
 - ±24mA @ 3.0V V_{CC}
- Uses patented noise/EMI reduction circuitry
- Latchup performance exceeds JEDEC 78 conditions
- ESD performance:
 - Human body model > 2000V
 - Machine model > 250V
- Leadless DQFN package

General Description

The VCX00 contains four 2-input NAND gates. This product is designed for low voltage (1.2V to 3.6V) $\rm V_{CC}$ applications with I/O compatibility up to 3.6V.

The VCX00 is fabricated with an advanced CMOS technology to achieve high-speed operation while maintaining low CMOS power dissipation.

Ordering Information

Order Number	Package Number	Package Description
74VCX00M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
74VCX00BQX ⁽¹⁾	MLP14A	14-Terminal Depopulated Quad Very-Thin Flat Pack No Leads (DQFN), JEDEC MO-241, 2.5 x 3.0mm
74VCX00MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

Note:

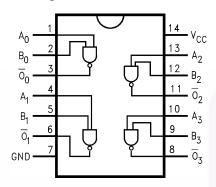
1. DQFN package available in Tape and Reel only.

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering number.

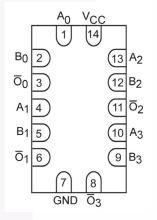
All packages are lead free per JEDEC: J-STD-020B standard.

Connection Diagrams

Pin Assignments for SOIC and TSSOP



Pad Assignments for DQFN



(Top View)

Pin Description

Pin Names	Description
A _n , B _n	Inputs
\overline{O}_n	Outputs

Logic Symbol

| Second Second

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Rating
V _{CC}	Supply Voltage	-0.5V to +4.6V
V _I	DC Input Voltage	-0.5V to 4.6V
Vo	DC Output Voltage	
	HIGH or LOW State ⁽²⁾	-0.5V to V _{CC} + 0.5V
	V _{CC} = 0V	-0.5V to 4.6V
I _{IK}	DC Input Diode Current, V _I < 0V	_50mA
I _{OK}	DC Output Diode Current	
	$V_O < 0V$	–50mA
	$V_O > V_{CC}$	+50mA
I _{OH} / I _{OL}	DC Output Source/Sink Current	±50mA
I _{CC} or GND	DC V _{CC} or Gound Current per Supply Pin ±100r	
T _{STG}	Storage Temperature Range	−65°C to +150°C

Note:

2. I_O Absolute Maximum Rating must be observed.

Recommended Operating Conditions⁽³⁾

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

Symbol	Parameter	Rating
V _{CC}	Power Supply Operating	1.2V to 3.6V
V _I	Input Voltage	-0.3V to 3.6V
V _O	Output Voltage, HIGH or LOW State	0V to V _{CC}
I _{OH} / I _{OL}	Output Current	
	$V_{CC} = 3.0V \text{ to } 3.6V$	±24mA
	$V_{CC} = 2.3V \text{ to } 2.7V$	±18mA
	$V_{CC} = 1.65V \text{ to } 2.3V$	±6mA
	V _{CC} = 1.4V to 1.6V	±2mA
	V _{CC} = 1.2V	± 100μA
T _A	Free Air Operating Temperature	-40°C to +85°C
Δt / ΔV	Minimum Input Edge Rate, $V_{IN} = 0.8V$ to 2.0V, $V_{CC} = 3.0V$	10ns/V

Note:

3. Floating or unused inputs must be held HIGH or LOW

DC Electrical Characteristics

Symbol	Parameter	V _{CC} (V)	Conditions	Min	Max	Units
V _{IH}	HIGH Level Input Voltage	2.7-3.6		2.0		V
		2.3-2.7		1.6		1
		1.65–2.3		0.65 × V _{CC}		1
		1.4-1.6		0.65 × V _{CC}		1
		1.2		0.65 × V _{CC}		1
V _{IL}	LOW Level Input Voltage	2.7-3.6			0.8	V
		2.3-2.7			0.7	1
		1.65-2.3			0.35 × V _{CC}	1
		1.4–1.6			0.35 × V _{CC}	1
		1.2			0.05 x V _{CC}	1
V _{OH}	HIGH Level Output Voltage	2.7–3.6	$I_{OH} = -100 \mu A$	V _{CC} - 0.2		V
		2.7	$I_{OH} = -12mA$	2.2		
		3.0	I _{OH} = -18mA	2.4		1
		3.0	$I_{OH} = -24 \text{mA}$	2.2		
		2.3–2.7	$I_{OH} = -100 \mu A$	V _{CC} - 0.2		1
		2.3	$I_{OH} = -6mA$	2.0		1
		2.3	$I_{OH} = -12\text{mA}$	1.8		
		2.3	$I_{OH} = -18\text{mA}$	1.7		1
	1.65–2.3	$I_{OH} = -100 \mu A$	V _{CC} - 0.2			
	1.65	$I_{OH} = -6mA$	1.25		1	
	1.4–1.6	$I_{OH} = -100 \mu A$	V _{CC} - 0.2			
	1.4	$I_{OH} = -2mA$	1.05		-	
	1.2	$I_{OH} = -100 \mu A$	V _{CC} - 0.2			
V _{OL}	LOW Level Output Voltage	2.7–3.6	$I_{OL} = 100 \mu A$		0.2	V
OL		2.7	I _{OL} = 12mA		0.4	
		3.0	I _{OL} = 18mA		0.4	1
		3.0	I _{OL} = 24mA		0.55	
		2.3–2.7	$I_{OL} = 100\mu A$		0.2	
		2.3	I _{OL} = 12mA		0.4	
		2.3	I _{OL} = 18mA		0.6	-
		1.65–2.3	$I_{OL} = 100\mu A$		0.2	-
		1.65	I _{OL} = 6mA		0.3	-
		1.4–1.6	$I_{OL} = 100 \mu A$		0.2	-
		1.4	$I_{OL} = 2mA$		0.35	
		1.2	$I_{OL} = 100\mu A$		0.05	
l _l	Input Leakage Current	1.4–3.6	$0 \le V_1 \le 3.6V$		±5.0	μA
I _{OZ}	3-STATE Output Leakage	1.4–3.6	$0 \le V_O \le 3.6V$, $V_I = V_{IH} \text{ or } V_{IL}$		±10	μΑ
lar-	Power-OFF Leakage Current	0	$0 \le (V_1, V_0) \le 3.6V$		10	μA
loff	Quiescent Supply Current	1.4–3.6			20	<u> </u>
I _{CC}	Quiescent Supply Current	1.4-3.0	$V_{I} = V_{CC} \text{ or GND}$ $V_{CC} \le (V_{I}, V_{O}) \le 3.6V^{(4)}$		±20	μA
	Increase in L. nor Innut	2726				
Δl _{CC}	Increase in I _{CC} per Input	2.7–3.6	$V_{IH} = V_{CC} - 0.6V$		750	μA

Note:

4. Outputs disabled or 3-STATE only.

AC Electrical Characteristics⁽⁵⁾

				T _A = -40°C to +85°C			Figure
Symbol	Parameter	V _{CC} (V)	Conditions	Min.	Max.	Units	Number
t _{PHL} , t _{PLH}	Propagation Delay	3.3 ± 0.3	$C_L = 30 pF, R_L = 500 \Omega$	0.6	2.8	ns	Fig. 1
		2.5 ± 0.2		0.8	3.7		Fig. 2
		1.8 ± 0.15		1.0	7.4		
		1.5 ± 0.1	$C_L = 15pF, R_L = 2k\Omega$	1.0	14.8		Fig. 3
		1.2		1.5	37.0		Fig. 4
toshl, toshh	Output to Output	3.3 ± 0.3	$C_L = 30 pF, R_L = 500 \Omega$		0.5	ns	
	Skew ⁽⁶⁾	2.5 ± 0.2			0.5		
		1.8 ± 0.15			0.75		
		1.5 ± 0.1	$C_L = 15pF, R_L = 2k\Omega$		1.5		
		1.2			1.5		

Note

- 5. For $C_L = 50 pF$, add approximately 300ps to the AC Maximum specification.
- Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}).

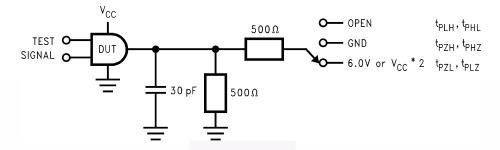
Dynamic Switching Characteristics

				T _A = 25°C	
Symbol	Parameter	V _{CC} (V)	Conditions	Typical	Unit
V _{OLP}	Quiet Output Dynamic Peak V _{OL}	1.8	$C_L = 30 pF, V_{IH} = V_{CC},$	0.25	V
		2.5	$V_{IL} = 0V$	0.6	
		3.3		0.8	
V _{OLV}	Quiet Output Dynamic Valley V _{OL}	1.8	$C_L = 30 pF, V_{IH} = V_{CC},$	-0.25	V
		2.5	$V_{IL} = 0V$	-0.6	
		3.3		-0.8	
V _{OHV}	Quiet Output Dynamic Valley V _{OH}	1.8	$C_L = 30 pF, V_{IH} = V_{CC},$	1.5	V
		2.5	$V_{IL} = 0V$	1.9	
		3.3		2.2]

Capacitance

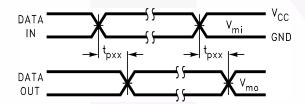
			T _A = +25°C	
Symbol	Parameter	Conditions	Typical	Units
C _{IN}	Input Capacitance	$V_1 = 0V \text{ or } V_{CC}, V_{CC} = 1.8V, 2.5V \text{ or } 3.3V$	6	pF
C _{OUT}	Output Capacitance	$V_{I} = 0V \text{ or } V_{CC}, V_{CC} = 1.8V, 2.5V \text{ or } 3.3V$	7	pF
C _{PD}	Power Dissipation Capacitance	V_I = 0V or V_{CC} , f = 10 MHz, V_{CC} = 1.8V, 2.5V or 3.3V	20	pF

AC Loading and Waveforms (V_{CC} 3.3V \pm 0.3V to 1.8V \pm 0.15V)



Test	Switch
t _{PLH} , t _{PHL}	Open

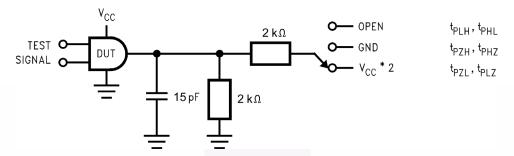
Figure 1. AC Test Circuit



	V _{CC}		
Symbol	3.3V ± 0.3V	2.5V ± 0.2V	1.8V ± 0.15V
V _{mi}	1.5V	V _{CC} / 2	V _{CC} / 2
V _{mo}	1.5V	V _{CC} / 2	V _{CC} / 2

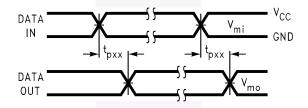
Figure 2. Waveform for Inverting and Non-inverting Functions

AC Loading and Waveforms (V_{CC} 1.5 \pm 0.1V to 1.2V)



Test	SWITCH
t _{PLH} , t _{PHL}	Open
t _{PZL} , t _{PLZ}	$V_{CC} \times 2$ at $V_{CC} = 1.5V \pm 0.1V$
t _{PZH} , t _{PHZ}	GND

Figure 3. AC Test Circuit



	V _{CC}
Symbol	1.5V ± 0.1V
V _{mi}	V _{CC} / 2
V _{mo}	V _{CC} / 2

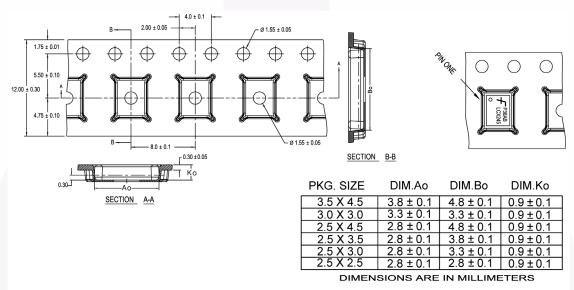
Figure 4. Waveform for Inverting and Non-Inverting Functions

Tape and Reel Specification

Tape Format for DQFN

Package Designator	Tape Section	Number of Cavities	Cavity Status	Cover Tape Status	
BQX	Leader (Start End)	125 (Typ.)	Empty	Sealed	
	Carrier	3000	Filled	Sealed	
Trailer (Hub End)		75 (Typ.)	Empty	Sealed	

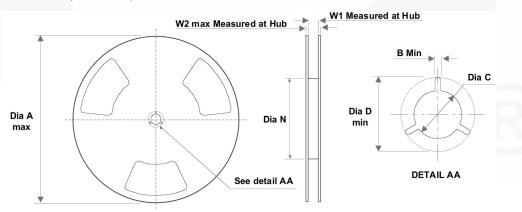
Tape Dimensions inches (millimeters)



NOTES: unless otherwise specified

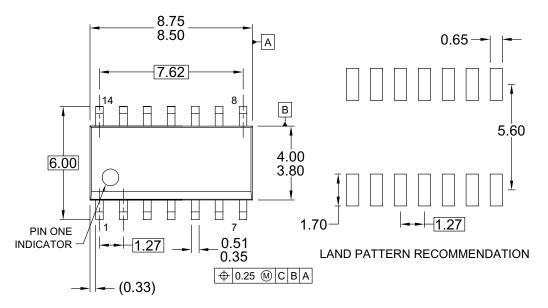
- 1. Cummulative pitch for feeding holes and cavities (chip pockets) not to exceed 0.008[0.20] over 10 pitch span.
- 2. Smallest allowable bending radius.
- 3. Thru hole inside cavity is centered within cavity.
- 4. Tolerance is $\pm 0.002[0.05]$ for these dimensions on all 12mm tapes.
- 5. Ao and Bo measured on a plane 0.120[0.30] above the bottom of the pocket.
- 6. Ko measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
- 7. Pocket position relative to sprocket hole measured as true position of pocket. Not pocket hole.
- 8. Controlling dimension is millimeter. Diemension in inches rounded

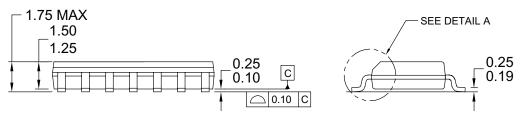
Reel Dimensions inches (millimeters)



Tape Size	Α	В	С	D	N	W1	W2
12mm	13.0 (330.0)	0.059 (1.50)	0.512 (13.00)	0.795 (20.20)	2.165 (55.00)	0.488 (12.4)	0.724 (18.4)

Physical Dimensions





NOTES: UNLESS OTHERWISE SPECIFIED

A) THIS PACKAGE CONFORMS TO JEDEC MS-012, VARIATION AB, ISSUE C,

0.50 X 45° ALL DIMENSIONS ARE IN MILLIMETERS. 0.25 DIMENSIONS DO NOT INCLUDE MOLD R0.10 GAGE PLANE LANDPATTERN STANDARD: R0.10 0.36

DETAIL A

SOIC127P600X145-14M

FLASH OR BURRS.

- DRAWING CONFORMS TO ASME Y14.5M-1994
- F) DRAWING FILE NAME: M14AREV13
- SCALE: 20:1 Figure 5. 14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow

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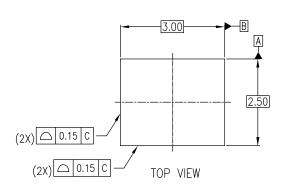
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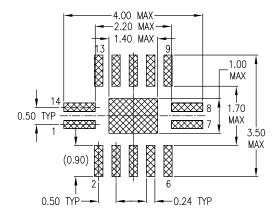
SEATING PLANE

0.90

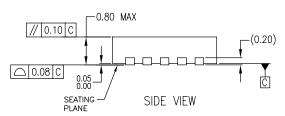
0.50 (1.04)

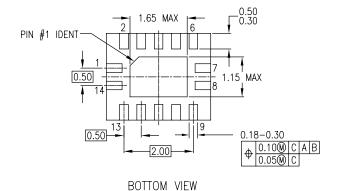
Physical Dimensions (Continued)





RECOMMENDED LAND PATTERN





NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-241, VARIATION AA
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994

MLP14ArevA

Figure 6. 14-Terminal Depopulated Quad Very-Thin Flat Pack No Leads (DQFN), JEDEC MO-241, 2.5 x 3.0mm

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Physical Dimensions (Continued) 5.0±0.1 -A-0.43 TYI 0.65 6.4 4.4±0.1 -B--1.65 3.2 □ 0.2 C B A PIN #1 IDENT. 6 10 LAND PATTERN RECOMMENDATION SEE DETAIL A ALL LEAD TIPS 0.90+0.15 1.2 MAX □ 0.1 C -0.10 0.09-0.20 -C-0.10±0.05 0.65 0.19 - 0.30⊕ 0.13M ABS CS 2.00°TOP & BOTTOM R0.09 min **GAGE PLANE** 0.25 0°-8° NOTES: A. CONFORMS TO JEDEC REGISTRATION MO-153. 0.6±0.1 SEATING PLANE R0.09min VARIATION AB, REF NOTE 6 1 00 **B. DIMENSIONS ARE IN MILLIMETERS DETAIL A**

- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS
- D. DIMENSIONING AND TOLERANCES PER ANSI Y14.5M, 1982
- E. LANDPATTERN STANDARD: SOP65P640X110-14M
- F. DRAWING FILE NAME: MTC14REV6

Figure 7. 14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

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- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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